


<b>Search Notes</b>  	<b>Application/Control No.</b>  10591943	<b>Applicant(s)/Patent Under Reexamination</b>  JU ET AL.
	<b>Examiner</b>  QUN SHEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
370	331, 250, 251, 252 combined with text	2/3/2010	QS
455	436, 445	2/3/2010	QS

SEARCH NOTES		
Search Notes	Date	Examiner
TEST SEARCH ON EAST	2/26/2010	QS
International search report	2/3/2010	QS
inventor search	2/3/2010	QS
NPL search	2/25/2010	QS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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